

February 2015

FDMA6676PZ Single P-Channel PowerTrench[®] MOSFET

-30 V, -11 A, 13.5 mΩ

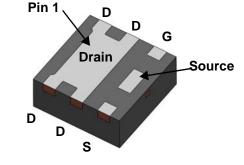
Features

- Max r_{DS(on)} = 13.5 mΩ @ V_{GS} = -10 V
- 25V V_{GS} Extended Operating Rating
- 30V V_{DS} Blocking
- 2x2mm Form Factor
- Low Profile 0.8 mm maximum
- Integrated Protection Diode
- RoHS Compliant
- Halogen Free

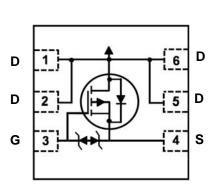


General Description

This device is an ultra low resistance P-Channel FET. It is designed for power line load switching applications and reverse polarity protection. It is especially optimized for voltage rails that can climb as high as 25V. Typical end systems include laptop computers, tablets and mobile phone. Applications include battery protection, input power line protection and charge path protection, including USB and other charge paths. The FDMA6676PZ has an enhanced V_{GS} rating of 25V specifically designed to simplify installation. When used as reverse polarity protection, with gate tied to ground and drain tied to V input, it is designed to support operating input voltages that can raise as high as 25V without the need for external Zener protection on the gate. Its small 2x2x0.8 form factor make it an ideal part for mobile and space constrained applications.



MicroFET 2X2 (Bottom View)



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			-30	V
V _{GS}	Gate to Source Voltage			±25	V
1	Drain Current -Continuous	T _A = 25 °C	(Note 1a)	-11	۸
D	-Pulsed		(Note 3)	-165	A
Power Dissipation		T _A = 25 °C	(Note 1a)	2.4	w
P _D Power Dissipatio	Power Dissipation	T _A = 25 °C	(Note 1b)	0.9	vv
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

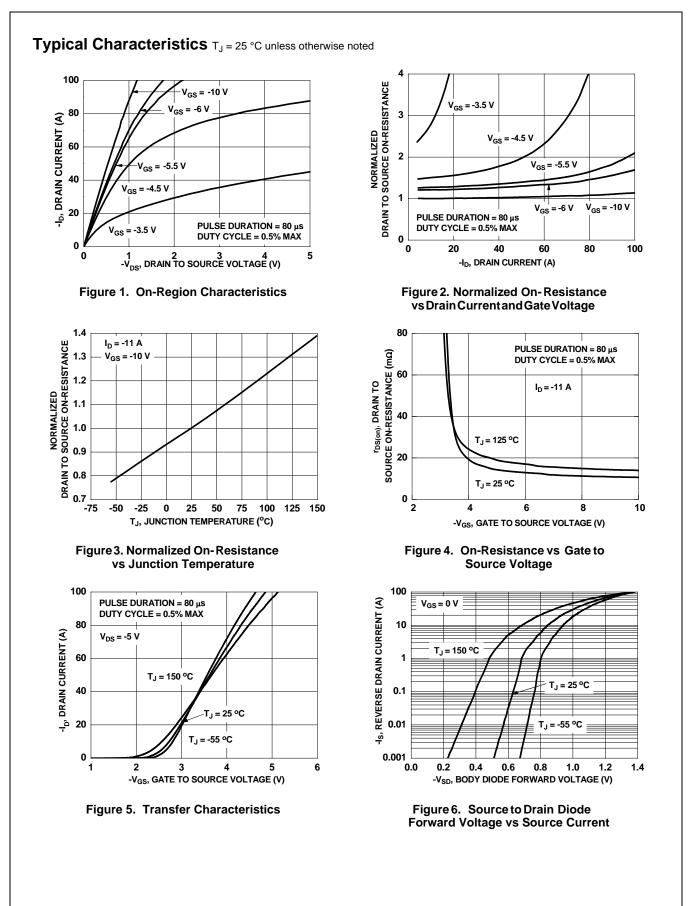
Thermal Characteristics

$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	52	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1b)	145	C/VV

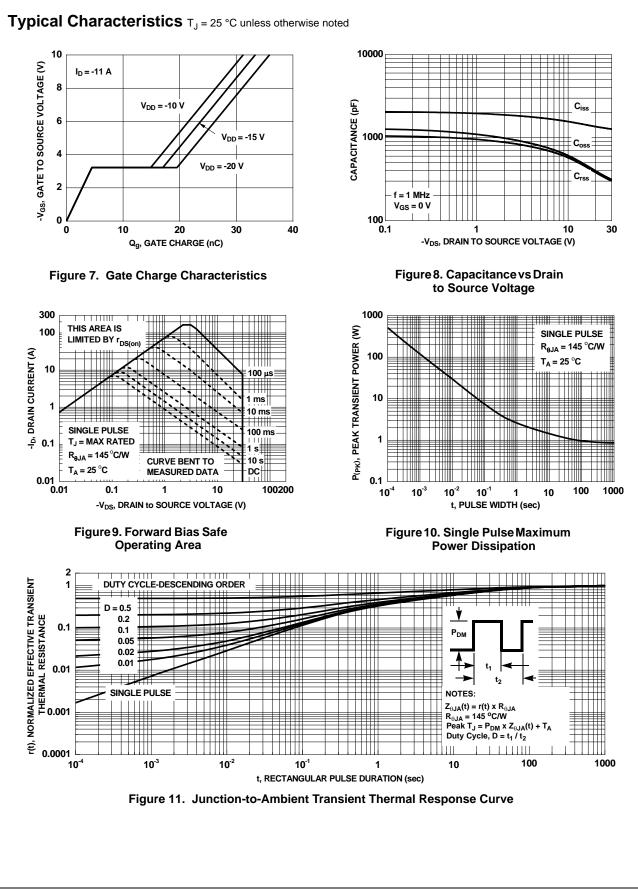
Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
676	FDMA6676PZ	MicroFET 2X2	7 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = -250 μA, V _{GS} = 0 V	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, referenced to 25 °C		-19		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 V, V_{GS} = 0 V$			-1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA
On Chara	otoristics					
	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \ \mu A$	-1.2	-2	-2.6	V
V _{GS(th)}	Gate to Source Threshold Voltage		-1.2	-2	-2.0	v
$\frac{\Delta V_{GS(th)}}{\Delta T_{.1}}$	Temperature Coefficient	I_D = -250 µA, referenced to 25 °C		5.9		mV/°
		V _{GS} = -10 V, I _D = -11 A		11	13.5	
r	Static Drain to Source On Resistance	V _{GS} = -4.5 V, I _D = -8 A		19	27	mO
r _{DS(on)} S		V _{GS} = -10 V, I _D = -11 A, T _J = 125 °C		14.5	21	- mΩ
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, \text{ I}_{D} = -11 \text{ A}$		38		S
				1		
•	Characteristics			1110	0400	- 5
C _{iss}	Input Capacitance	V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz		1440 477	2160 720	pF
C _{oss}	Output Capacitance Reverse Transfer Capacitance				690	pF
C _{rss}				458 12	690	pF
R _g	Gate Resistance			12		Ω
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time			8.8	18	ns
t _r	Rise Time	$V_{DD} = -15 \text{ V}, \text{ I}_{D} = -11 \text{ A},$		19	34	ns
t _{d(off)}	Turn-Off Delay Time			87	139	ns
t _f	Fall Time			72	115	ns
Q _g	Total Gate Charge	$V_{GS} = 0 V \text{ to } -10 V$		33	46	nC
*	Total Gate Charge	$V_{GS} = 0 V \text{ to } -4.5 V V_{DD} = -15 V,$		20	28	nC
Q _n						-
Q _g Q _{gs}	Gate to Source Charge	$I_{\rm D} = -11 \text{ A}$		4.5		nC
Q _{gs}	Gate to Source Charge Gate to Drain "Miller" Charge	I _D = -11 A		4.5 13		nC
Q _{gs} Q _{gd}	Gate to Drain "Miller" Charge	I _D = -11 A				
Q _{gs} Q _{gd}	-	I _D = -11 A		13		nC
Q _{gs} Q _{gd} Drain-Sou	Gate to Drain "Miller" Charge	$I_D = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = -2 \text{ A}$ (Note 2)		-0.7	-1.2	nC V
Q _{gs} Q _{gd}	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage	I _D = -11 A		13	-1.2 -1.4	nC
Q _{gs} Q _{gd} Drain-Sou V _{SD} t _{rr}	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note 2})$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note 2})$		-0.7 -0.9 31		nC V
Q _{gs} Q _{gd} Drain-Sou V _{SD} t _{rr} Q _{rr}	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage	$I_D = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = -2 \text{ A}$ (Note 2)		-0.7 -0.9	-1.4	nC V V
Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Charge	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} \qquad (\text{Note 2})$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} \qquad (\text{Note 2})$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	determine	-0.7 -0.9 31 9	-1.4 50 18	nC V V ns nC
Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Charge ined with the device mounted on a 1 in ² pad 2 oz copper p	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note } 2)$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note } 2)$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ where the standard of FR-4 material. R _{0CA} is		-0.7 -0.9 31 9 d by the user	-1.4 50 18	nC V V ns nC
Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Charge	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note 2})$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note 2})$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ where the second of FR-4 material. R _{0CA} is the second seco	15 °C/W wh	-0.7 -0.9 31 9	-1.4 50 18 's board des on a	nC V V ns nC
Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Charge ined with the device mounted on a 1 in ² pad 2 oz copper p a. 52 °C/W, when mo	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note 2})$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note 2})$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ where the second of FR-4 material. R _{0CA} is the second seco	15 °C/W wh	-0.7 -0.9 31 9 d by the user	-1.4 50 18 's board des on a	nC V V ns nC
Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Charge ined with the device mounted on a 1 in ² pad 2 oz copper p a. 52 °C/W when mc on a 1 in ² pad of 2	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note 2})$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note 2})$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ where the second of FR-4 material. R _{0CA} is the second seco	15 °C/W wh	-0.7 -0.9 31 9 d by the user	-1.4 50 18 's board des on a	nC V V ns nC
Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Charge ined with the device mounted on a 1 in ² pad 2 oz copper p a. 52 °C/W, when mo	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note 2})$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note 2})$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ where the second of FR-4 material. R _{0CA} is the second seco	15 °C/W wh	-0.7 -0.9 31 9 d by the user	-1.4 50 18 's board des on a	nC V V ns nC
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Q_{gs} Q_{gd} Drain-Sou V_{SD} t_{rr} Q_{rr} NOTES:	Gate to Drain "Miller" Charge Irce Diode Characteristics Source to Drain Diode Forward Voltage Reverse Recovery Time Reverse Recovery Time Reverse Recovery Charge ined with the device mounted on a 1 in² pad 2 oz copper p a. 52 °C/W when moon on a 1 in² pad of 2	$I_{D} = -11 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A} (\text{Note } 2)$ $V_{GS} = 0 \text{ V}, I_{S} = -11 \text{ A} (\text{Note } 2)$ $I_{F} = -11 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ Pad on a 1.5 x 1.5 in. board of FR-4 material. R _{0CA} is builted 2 oz copper.	15 °C/W wh	-0.7 -0.9 31 9 d by the user	-1.4 50 18 's board des on a	nC V V ns nC

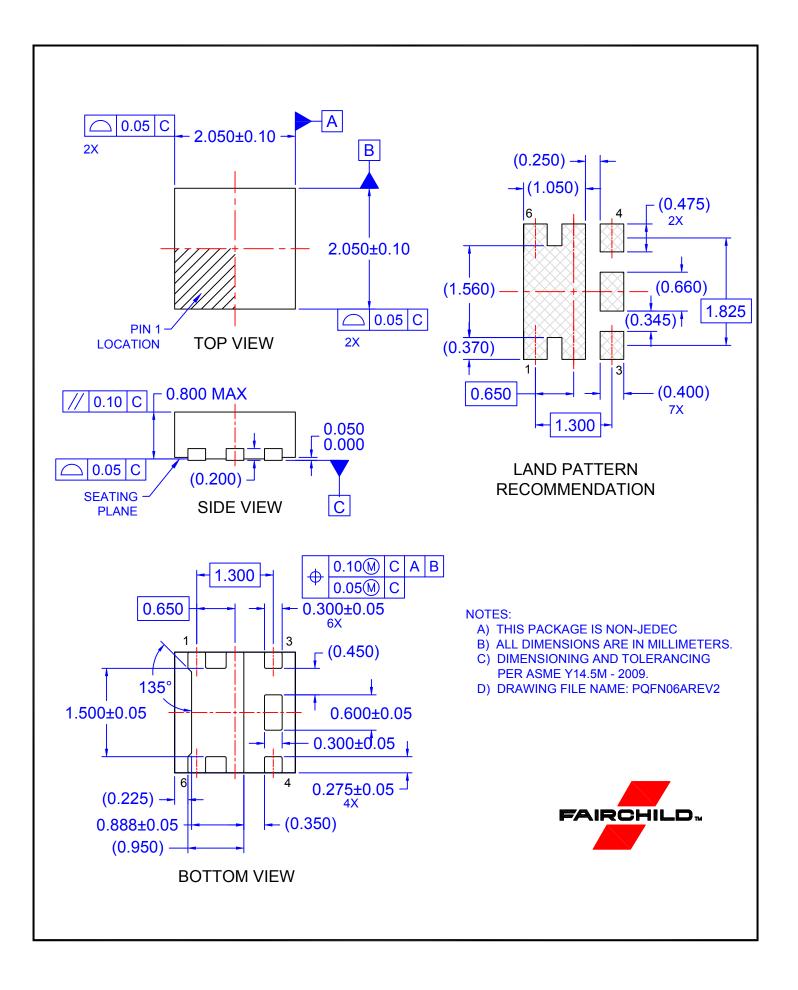


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